

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/666,606	CHENG, YU-CHIH	
Examiner	Art Unit	
Kevin M. Nguyen	2674	

SEARCHED					
Class	Subclass	Date	Examiner		
345	156, 163-167	2/23/2006	KMN		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Text and inventor search, see search history printout.	2/23/2006	KMN		